Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/509,195	CHRISTENSEN, LEIF	
Examiner	Art Unit	

Francis T. Palo

3644

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH STRATEGY)		
·	DATE	EXMR
Updated Search	10/26/2007	FP
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